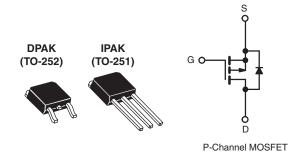


Vishay Siliconix

## **Power MOSFET**

| PRODUCT SUMMARY                 |                               |  |  |  |  |
|---------------------------------|-------------------------------|--|--|--|--|
| V <sub>DS</sub> (V)             | - 100                         |  |  |  |  |
| $R_{DS(on)}\left(\Omega\right)$ | V <sub>GS</sub> = - 10 V 0.60 |  |  |  |  |
| Q <sub>g</sub> (Max.) (nC)      | 18                            |  |  |  |  |
| Q <sub>gs</sub> (nC)            | 3.0                           |  |  |  |  |
| Q <sub>gd</sub> (nC)            | 9.0                           |  |  |  |  |
| Configuration                   | Single                        |  |  |  |  |



### **FEATURES**

- Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- Surface Mount (IRFR9120/SiHFR9120)
- Straight Lead (IRFU9120/SiHFU9120)
- · Available in Tape and Reel
- P-Channel
- · Fast Switching
- Lead (Pb)-free Available

### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effictiveness.

The DPAK is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU/SiHFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 W are possible in typical surcace mount applications.

| ORDERING INFORMATION |               |                                |                             |               |  |  |
|----------------------|---------------|--------------------------------|-----------------------------|---------------|--|--|
| Package              | DPAK (TO-252) | DPAK (TO-252)                  | DPAK (TO-252)               | IPAK (TO-251) |  |  |
| Lead (Pb)-free       | IRFR9120PbF   | IRFR9120TRPbFa IRFR9120TRLPbFa |                             | IRFU9120PbF   |  |  |
|                      | SiHFR9120-E3  | SiHFR9120T-E3 <sup>a</sup>     | SiHFR9120TL-E3 <sup>a</sup> | SiHFU9120-E3  |  |  |
| SnPb                 | IRFR9120      | IRFR9120TRa                    | IRFR9120TRLa                | IRFU9120PbF   |  |  |
| SHED                 | SiHFR9120     | SiHFR9120Ta                    | SiHFR9120TL <sup>a</sup>    | SiHFU9120     |  |  |

### Note

a. See device orientation.

| ABSOLUTE MAXIMUM RATINGS                           | T <sub>C</sub> = 25 °C, unless otherv  | vise noted     |       |      |  |
|--|--|----------------|-------|------|--|
| PARAMETER  | SYMBOL   | LIMIT          | UNIT  |      |  |
| Drain-Source Voltage                               |  | $V_{DS}$       | - 100 |      |  |
| Gate-Source Voltage                                |  | $V_{GS}$       | ± 20  | V    |  |
| Continuous Drain Current                           | $V_{GS}$ at - 10 V $T_{C} = 25 ^{\circ}\text{C}$<br>$T_{C} = 100 ^{\circ}\text{C}$ | 1-             | - 5.6 |      |  |
|  | $T_C = 100 ^{\circ}$ C   | I <sub>D</sub> | - 3.6 | Α    |  |
| Pulsed Drain Current <sup>a</sup>                  | I <sub>DM</sub>  | - 22           |       |      |  |
| Linear Derating Factor                             |  | 0.33           | W/°C  |      |  |
| Linear Derating Factor (PCB Mount) <sup>e</sup>    |  | 0.020          |       |      |  |
| Single Pulse Avalanche Energy <sup>b</sup>         | E <sub>AS</sub>  | 210            | mJ    |      |  |
| Repetitive Avalanche Current <sup>a</sup>          | I <sub>AR</sub>  | - 5.6          | Α     |      |  |
| Repetitive Avalanche Energy <sup>a</sup>           | E <sub>AR</sub>  | 4.2            | mJ    |      |  |
| Maximum Power Dissipation                          | T <sub>C</sub> = 25 °C   | Б              | 42    | w    |  |
| Maximum Power Dissipation (PCB Mount) <sup>e</sup> | T <sub>A</sub> = 25 °C   | P <sub>D</sub> | 2.5   | ] vv |  |
| Peak Diode Recovery dV/dtc                         | dV/dt  | - 5.5          | V/ns  |      |  |

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFR9120, IRFU9120, SiHFR9120, SiHFU9120

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| ABSOLUTE MAXIMUM RATINGS T <sub>C</sub> = 25 °C, unless otherwise noted |                                   |               |                  |   |  |  |
|---|-----------------------------------|---------------|------------------|---|--|--|
| PARAMETER   | SYMBOL                            | LIMIT         | UNIT             |   |  |  |
| Operating Junction and Storage Temperature Range                        | T <sub>J</sub> , T <sub>stg</sub> | - 55 to + 150 | °C               |   |  |  |
| Soldering Recommendations (Peak Temperature)                            | for 10 s                          |               | 260 <sup>d</sup> | C |  |  |

### **Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 10 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AS}$  = 5.6 A (see fig. 12). c.  $I_{SD}$  < 6.8 A, dI/dt < 110 A/ $\mu$ s,  $V_{DD}$  <  $V_{DS}$ ,  $T_J$  < 150 °C.

- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material).

| THERMAL RESISTANCE RATINGS                           |                   |      |      |      |      |  |
|--|-------------------|------|------|------|------|--|
| PARAMETER  | SYMBOL            | MIN. | TYP. | MAX. | UNIT |  |
| Maximum Junction-to-Ambient                          | R <sub>thJA</sub> | -    | -    | 110  |      |  |
| Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup> | R <sub>thJA</sub> | -    | -    | 50   | °C/W |  |
| Maximum Junction-to-Case (Drain)                     | R <sub>thJC</sub> | -    | -    | 3.0  |      |  |

### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

| PARAMETER                               | SYMBOL                | TES   | MIN.  | TYP.  | MAX.    | UNIT  |      |
|---|-----------------------|---|---|-------|---------|-------|------|
| Static                                  |                       |   |   |       |         |       |      |
| Drain-Source Breakdown Voltage          | V <sub>DS</sub>       | V <sub>GS</sub> =   | 0 V, I <sub>D</sub> = - 250 μA  | - 100 | -       | -     | V    |
| V <sub>DS</sub> Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Reference   | e to 25 °C, I <sub>D</sub> = - 1 mA   | -     | - 0.098 | -     | V/°C |
| Gate-Source Threshold Voltage           | V <sub>GS(th)</sub>   | V <sub>DS</sub> =   | V <sub>GS</sub> , I <sub>D</sub> = - 250 μA                                       | - 2.0 | -       | - 4.0 | V    |
| Gate-Source Leakage                     | I <sub>GSS</sub>      | ,   | $V_{GS} = \pm 20 \text{ V}$   | -     | -       | ± 100 | nA   |
| 7 0 1 1/1 5 1 0 1                       | ,                     | V <sub>DS</sub> =   | - 100 V, V <sub>GS</sub> = 0 V  | -     | -       | - 100 | μΑ   |
| Zero Gate Voltage Drain Current         | I <sub>DSS</sub>      | V <sub>DS</sub> = - 80 V  | , V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C                                  | -     | -       | - 500 |      |
| Drain-Source On-State Resistance        | R <sub>DS(on)</sub>   | V <sub>GS</sub> = - 10 V  | I <sub>D</sub> = - 3.4 A <sup>b</sup>   | -     | -       | 0.60  | Ω    |
| Forward Transconductance                | 9 <sub>fs</sub>       | V <sub>DS</sub> = - 50 V, I <sub>D</sub> = - 3.4 A  |   | 1.5   | -       | -     | S    |
| Dynamic                                 |                       |   |   |       |         |       |      |
| Input Capacitance                       | C <sub>iss</sub>      | $V_{GS} = 0 \text{ V},$ $V_{DS} = -25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. 5}$ |   | -     | 390     | -     | pF   |
| Output Capacitance                      | C <sub>oss</sub>      |   |   | -     | 170     | -     |      |
| Reverse Transfer Capacitance            | C <sub>rss</sub>      |   |   | -     | 45      | -     |      |
| Total Gate Charge                       | Qg                    |   |   | -     | -       | 18    | nC   |
| Gate-Source Charge                      | Q <sub>gs</sub>       | V <sub>GS</sub> = - 10 V  | $I_D = -6.8 \text{ A}, V_{DS} = -80 \text{ V},$<br>see fig. 6 and 13 <sup>b</sup> | -     | -       | 3.0   |      |
| Gate-Drain Charge                       | $Q_{gd}$              |   |   | -     | -       | 9.0   |      |
| Turn-On Delay Time                      | t <sub>d(on)</sub>    |   |   | -     | 9.6     | -     |      |
| Rise Time                               | t <sub>r</sub>        | $V_{DD} = 0$  | V <sub>DD</sub> = - 50 V, I <sub>D</sub> = - 6.8 A,                               |       | 29      | -     |      |
| Turn-Off Delay Time                     | t <sub>d(off)</sub>   | $R_G = 18 \Omega$ , $R_D = 7.1 \Omega$ , see fig. $10^b$                                    |   | -     | 21      | -     | ns   |
| Fall Time                               | t <sub>f</sub>        | 7   | -   | 25    | -       |       |      |
| Internal Drain Inductance               | L <sub>D</sub>        | Between lead,<br>6 mm (0.25") from  |   | -     | 4.5     | -     | mll  |
| Internal Source Inductance              | L <sub>S</sub>        | package and center of die contact   |   | -     | 7.5     | -     | - nH |

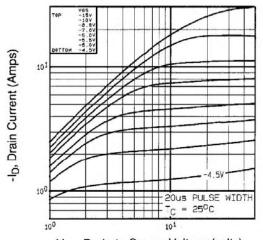
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| <b>SPECIFICATIONS</b> T <sub>J</sub> = 25 °C, unless otherwise noted |                 |   |            |            |                        |      |  |  |
|--|-----------------|---|------------|------------|------------------------|------|--|--|
| PARAMETER  | SYMBOL          | TEST CONDITIONS   | MIN.       | TYP.       | MAX.                   | UNIT |  |  |
| Drain-Source Body Diode Characteristics                              |                 |   |            |            |                        |      |  |  |
| Continuous Source-Drain Diode Current                                | I <sub>S</sub>  | MOSFET symbol showing the   | -          | 1          | - 5.6                  | Α    |  |  |
| Pulsed Diode Forward Current <sup>a</sup>                            | I <sub>SM</sub> | integral reverse p - n junction diode   | -          | -          | - 22                   | A    |  |  |
| Body Diode Voltage   | $V_{SD}$        | $T_J = 25  ^{\circ}\text{C},  I_S = -5.6  \text{A},  V_{GS} = 0  \text{V}^b$                        | -          | -          | - 6.3                  | ٧    |  |  |
| Body Diode Reverse Recovery Time                                     | t <sub>rr</sub> | T <sub>J</sub> = 25 °C, I <sub>F</sub> = - 6.8 A, dI/dt = 100 A/μs <sup>b</sup>                     | -          | 100        | 200                    | ns   |  |  |
| Body Diode Reverse Recovery Charge                                   | Q <sub>rr</sub> | $I_{J} = 25 \text{ G}, I_{F} = -6.8 \text{ A}, \text{ di/dt} = 100 \text{ A/} \mu \text{S}^{\circ}$ | -          | 0.33       | 0.66                   | μC   |  |  |
| Forward Turn-On Time   | t <sub>on</sub> | Intrinsic turn-on time is negligible (turn  | -on is don | ninated by | y L <sub>S</sub> and L | _D)  |  |  |

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.

### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



-VDS, Drain-to-Source Voltage (volts)

Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C

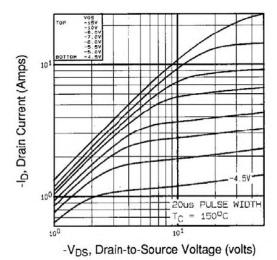
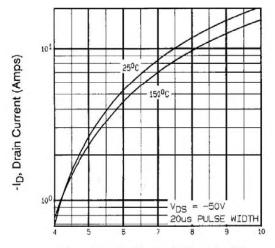


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C



-VGS, Gate-to-Source Voltage (volts) Fig. 3 - Typical Transfer Characteristics

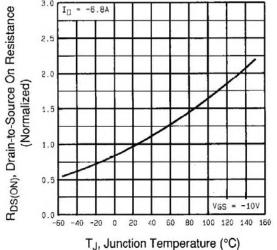


Fig. 4 - Normalized On-Resistance vs. Temperature

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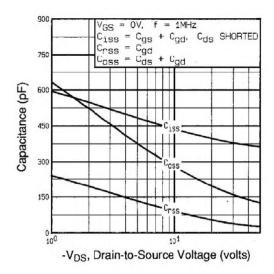


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

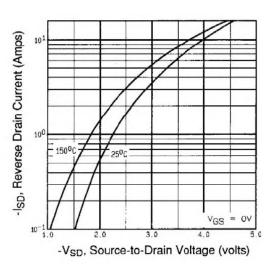


Fig. 7 - Typical Source-Drain Diode Forward Voltage

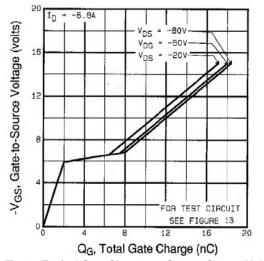


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

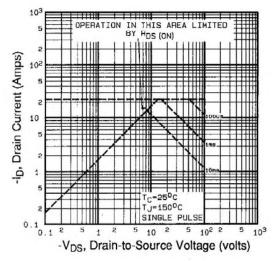


Fig. 8 - Maximum Safe Operating Area



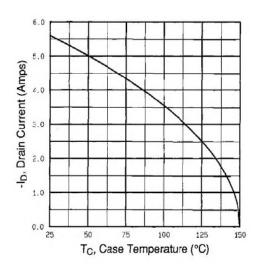


Fig. 9 - Maximum Drain Current vs. Case Temperature

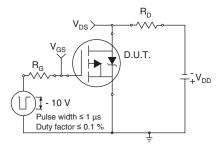


Fig. 10a - Switching Time Test Circuit

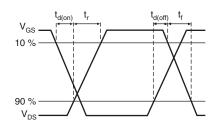


Fig. 10b - Switching Time Waveforms

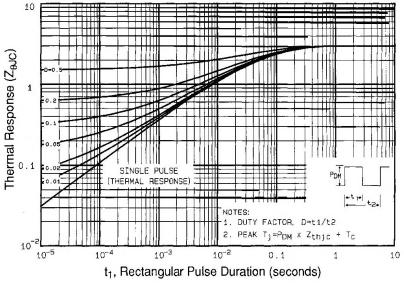


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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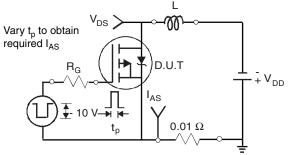


Fig. 12a - Unclamped Inductive Test Circuit

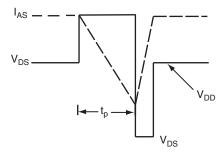


Fig. 12b - Unclamped Inductive Waveforms

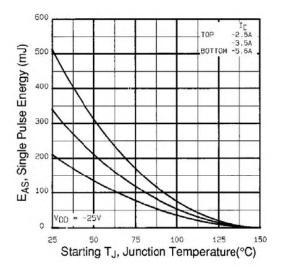


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

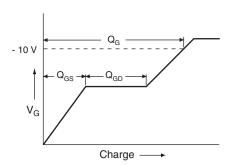


Fig. 13a - Basic Gate Charge Waveform

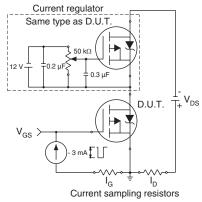
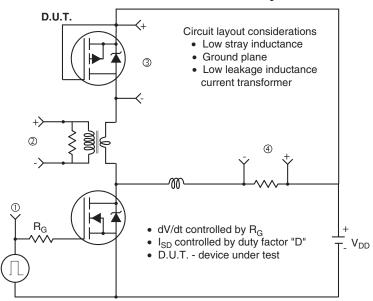


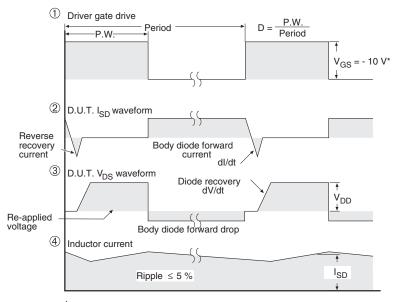
Fig. 13b - Gate Charge Test Circuit

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## Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver



V<sub>GS</sub> = - 5 V for logic level and - 3 V drive devices

Fig. 14 - For P-Channel

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